

SW38N60K-VB Datasheet

N-Channel 600 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V) at T _J max.	600					
R _{DS(on)} at 25 °C (Ω)	$V_{GS} = 10 V$	0.07				
Q _g max. (nC)	263					
Q _{gs} (nC)	41					
Q _{gd} (nC)	72					
Configuration	Single					

FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)



G Q S

N-Channel MOSFET

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-Source Voltage			V _{DS}	600	V				
Gate-Source Voltage			V _{GS}	± 30					
Continuous Drain Current (T _J = 150 °C)	V at 10 V	T _C = 25 °C T _C = 100 °C	- I _D	46					
	V _{GS} at 10 V	T _C = 100 °C		29	А				
Pulsed Drain Current ^a			I _{DM}	139					
Linear Derating Factor				3.3	W/°C				
Single Pulse Avalanche Energy ^b			E _{AS}	1410	mJ				
Maximum Power Dissipation			PD	417	W				
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C				
Drain-Source Voltage Slope	T _J = 125 °C		-1)//-14	37					
Reverse Diode dV/dt ^d		dV/dt	9	V/ns					
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C				

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 $\Omega,$ I_{AS} = 10 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D, \, dI/dt$ = 100 A/µs, starting T_J = 25 °C.



THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 40							
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.3				°C/W			
SPECIFICATIONS ($T_J = 25 \ ^{\circ}C$, u	nless otherwi	se noted)							
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D =	250 µA	650	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.70	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	V _{DS} = V _{GS} , I _D = 250 μA		2	-	4	V	
Osta Cauraa Laakaara		$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA		
Gate-Source Leakage	I _{GSS}			-	-	± 1	μA		
Zero Gate Voltage Drain Current		V _{DS} =	$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	1		
	IDSS	V _{DS} = 520 V	/, V _{GS} = 0 \	/, T _J = 125 °C	-	-	25	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I	_D = 24 A	-	0.07	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = 30 V, I _D = 24 A		-	16.7	-	S		
Dynamic								-	
Input Capacitance	C _{iss}		V _{GS} = 0 V,		-	5182	-		
Output Capacitance	C _{oss}	$V_{DS} = 100 V,$ f = 1 MHz		-	251	-	pF		
Reverse Transfer Capacitance	C _{rss}			-	1	-			
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{\rm DS}$ = 0 V to 520 V, $V_{\rm GS}$ = 0 V		-	192	-			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-			
Total Gate Charge	Qg				-	172	263		
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 24 \text{ A}, V_{DS} = 520 \text{ V}$		-	41	-	nC		
Gate-Drain Charge	Q _{gd}				-	72	-		
Turn-On Delay Time	t _{d(on)}	V_{DD} = 520 V, I _D = 6 A, V _{GS} = 10 V, R _g = 9.1 Ω		-	37	84	ns		
Rise Time	t _r			-	77	121			
Turn-Off Delay Time	t _{d(off)}			-	156	234			
Fall Time	t _f			-	93	196			
Gate Input Resistance	Rg	f = 1 MHz, open drain		-	0.64	-	Ω		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	MOSFET symbol showing the		-	-	47		
Pulsed Diode Forward Current	I _{SM}	integral reverse p - n junction diode		-	-	139	A		
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		-	0.9	1.2	V		
Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 24 \text{ A},$ dl/dt = 100 A/ μ s, V _R = 25 V		-	753	1506	ns		
Reverse Recovery Charge	Q _{rr}			-	14	28	μC		
Reverse Recovery Current	I _{RRM}			-	28		A		

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPCIAL CHARACTERISTICS (25 °C, unless otherwise noted)

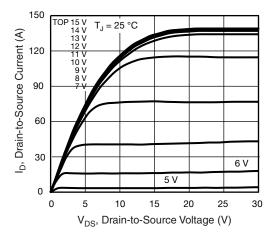


Fig. 1 - Typical Output Characteristics

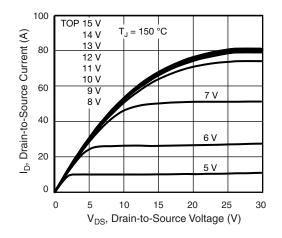


Fig. 2 - Typical Output Characteristics

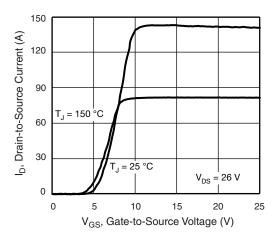


Fig. 3 - Typical Transfer Characteristics

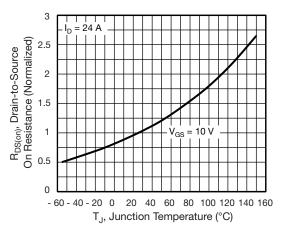


Fig. 4 - Normalized On-Resistance vs. Temperature

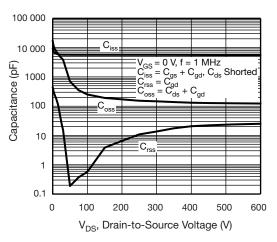


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

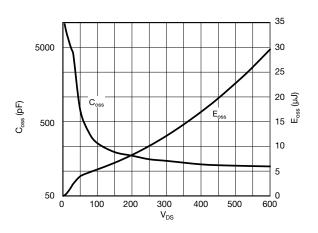


Fig. 6 - Coss and Eoss vs. VDS

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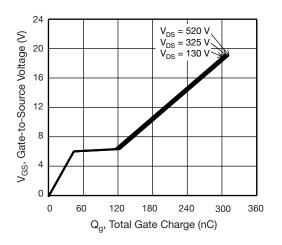


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

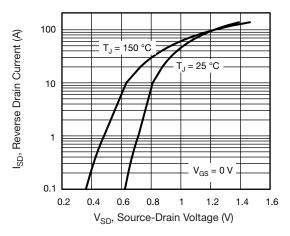


Fig. 8 - Typical Source-Drain Diode Forward Voltage

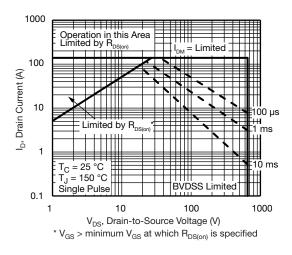
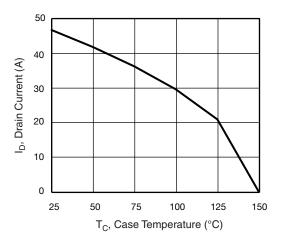


Fig. 9 - Maximum Safe Operating Area



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Fig. 10 - Maximum Drain Current vs. Case Temperature

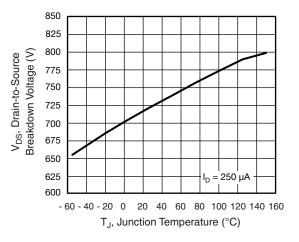
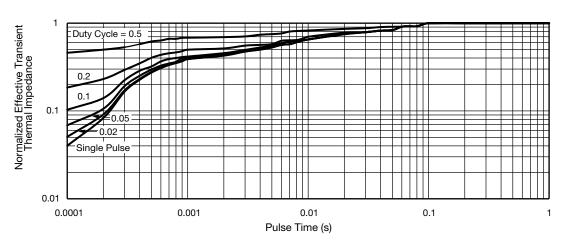


Fig. 11 - Temperature vs. Drain-to-Source Voltage





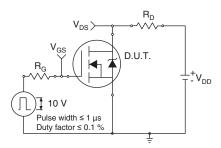


Fig. 13 - Switching Time Test Circuit

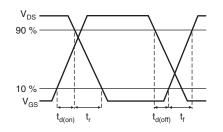


Fig. 14 - Switching Time Waveforms

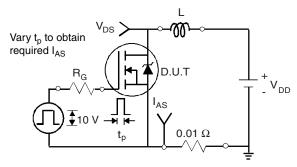


Fig. 15 - Unclamped Inductive Test Circuit

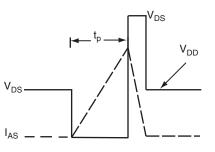


Fig. 16 - Unclamped Inductive Waveforms

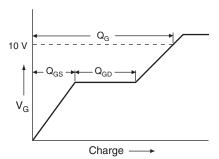


Fig. 17 - Basic Gate Charge Waveform

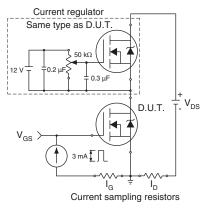


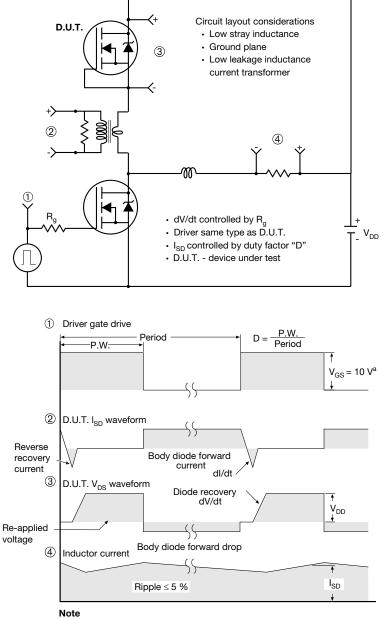
Fig. 18 - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

Fig. 19 - For N-Channel



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